Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/561,980	MIKUBO ET AL.	
Examiner	Art Unit	
Jean F. Duverne	2839	

SEARCHED			
Class	Subclass	Date	Examiner
361	699	4/28/2007	JFD
	695-698		
	687-692		
	701-703	4/28/2007	JFD
1			
		:	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		<u></u>	
<u> </u>	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
•	DATE	EXMR	
0			